Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/822,898	CLAY ET AL.	
Examiner	Art Unit	
Ba Huyah	2179	

	SEARCHED				
Class	Subclass	Date	Examiner		
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
East: USpat, USpgpub, Epo, Jpo, Derwent, IBM-tdb files search updated	6/12/2006			
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